

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10782231	MOELLER ET AL.
	Examiner	Art Unit
	Kim, David S	2613

SEARCHED

Class	Subclass	Date	Examiner
398	155,202	9-1-09	lp

SEARCH NOTES

Search Notes	Date	Examiner
reviewed references in U.S. Patent Application No. 10/730,413	12/22/2006	DSK
EAST search - see search history printout	12/22/2006	DSK
www.google.com - search terms: or gate nand	12/22/2006	DSK
EAST search - see search history printout	10/15/2007	DSK
www.google.com - various combinations of the following terms: NRZ pulse broadening widens dispersion eye diagram -spm	10/15/2007	DSK
scholar.google.com - various combinations of the following terms: NRZ pulse broadening widens broaden widen	10/15/2007	DSK
EAST search - see search history printout	12/19, 12/20/2008	DSK
www.google.com - various combinations of the following terms: duobinary waveform NRZ RZ "sampling window" "sampling point"	12/19, 12/20/2008	DSK
scholar.google.com - various combinations of the following terms: duobinary duty cycle 100 NRZ waveform RZ "sampling window" "sampling point" eye integrating window diagram narrow integration sampling	12/19, 12/20/2008	DSK

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
398	155,202	9-1-09	lp